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Team Nexperia

## **BUK9575-100A**



# N-channel TrenchMOS logic level FET Rev. 3 — 26 April 2011

**Product data sheet** 

#### **Product profile** 1.

## 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features and benefits

■ AEC Q101 compliant

Low conduction losses due to low on-state resistance

## 1.3 Applications

Automotive and general purpose power switching

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	-	100	V
$I_D$	drain current	T <sub>mb</sub> = 25 °C	-	-	23	Α
P <sub>tot</sub>	total power dissipation		-	-	98	W
Static chara	acteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A};$ $T_j = 25 \text{ °C}$	- 55	72	mΩ	
		$V_{GS} = 5 \text{ V}; I_D = 10 \text{ A};$ $T_j = 25 \text{ °C}$		60	75	mΩ
Avalanche ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 14.2 \text{ A; } V_{sup} \leq 25 \text{ V;} \\ R_{GS} &= 50  \Omega;  V_{GS} = 5 \text{ V;} \\ T_{j(init)} &= 25 ^{\circ}\text{C; } \text{ unclamped} \end{split}$	-	-	100	mJ



## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain	mb	D
3	S	source		G (FA)
mb	D	mounting base; connected to drain		mbb076 S
			SOT78A (TO-220AB)	

## 3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BUK9575-100A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A		

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	100	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	100	V
$V_{GS}$	gate-source voltage		-15	15	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 100 °C	-	16	Α
		T <sub>mb</sub> = 25 °C	-	23	Α
I <sub>DM</sub>	peak drain current	T <sub>mb</sub> = 25 °C; pulsed	-	91	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C	-	98	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drain	n diode				
Is	source current	T <sub>mb</sub> = 25 °C	-	23	Α
I <sub>SM</sub>	peak source current	pulsed; T <sub>mb</sub> = 25 °C	-	92	Α
Avalanche ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 14.2 A; $V_{sup} \le$ 25 V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped	-	100	mJ

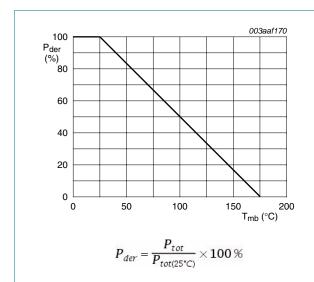
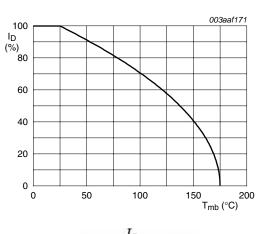


Fig 1. Normalized total power dissipation as a function of mounting base temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

 $V_{GS} \ge 5 \text{ V}$ 

Fig 2. Normalized continuous drain current as a function of mounting base temperature

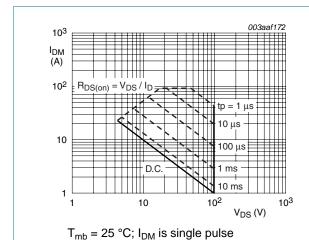


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

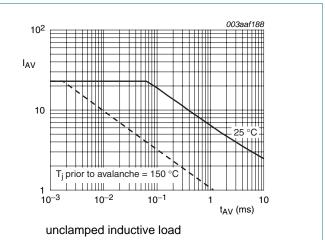


Fig 4. Single-shot avalanche rating; avalanche current as a function of avalanche period

### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base		-	-	1.5	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	-	60	-	K/W

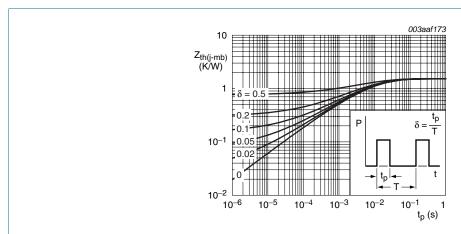


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	100	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	89	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C}$	0.5	-	-	V
	voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}$	-	-	2.3	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
		$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nΑ
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nΑ
R <sub>DSon</sub>	drain-source on-state	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C	-	55	72	mΩ
	resistance	V <sub>GS</sub> = 5 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C	-	-	188	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C}$	-	61	84	mΩ
		V <sub>GS</sub> = 5 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C	-	60	75	mΩ
Dynamic	characteristics	·				
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	1278	1704	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C	-	129	155	рF
C <sub>rss</sub>	reverse transfer capacitance		-	88	120	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 5 \text{ V};$	-	13	20	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	120	168	ns
t <sub>d(off)</sub>	turn-off delay time		-	58	87	ns
t <sub>f</sub>	fall time		-	57	86	ns
L <sub>D</sub>	internal drain inductance	from drain lead 6 mm from package to centre of die; $T_j = 25$ °C	-	4.5	-	nΗ
		from contact screw on tab to centre of die; $T_j = 25  ^{\circ}\text{C}$	-	3.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-di	rain diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.85	1.2	V
		$I_S = 23 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	1.1	-	V
t <sub>rr</sub>	reverse recovery time	$I_S = 23 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	63	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	0.22	-	μC

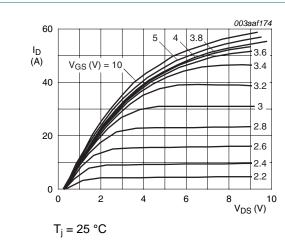


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

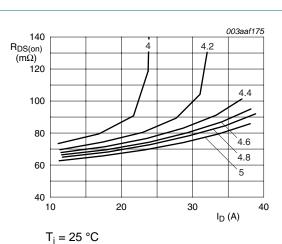


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

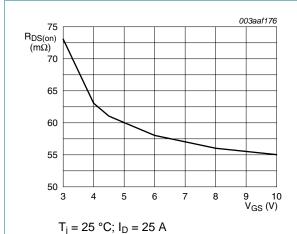


Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values

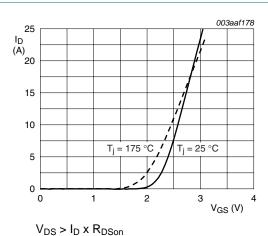


Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values

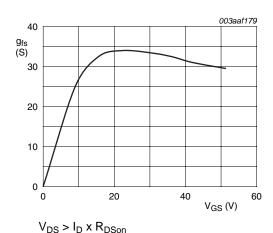


Fig 10. Forward transconductance as a function of drain current; typical values

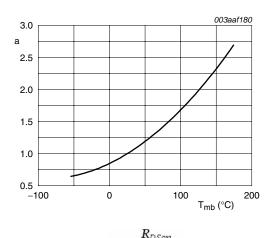


Fig 11. Normalized drain-source on-state resistance factor as a function of junction temperature

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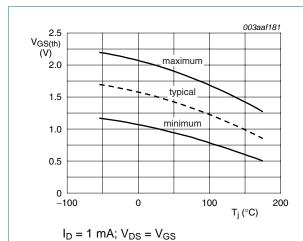
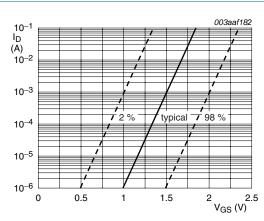
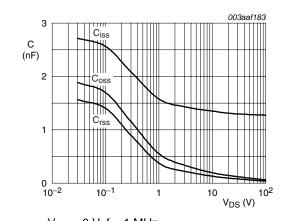


Fig 12. Gate-source threshold voltage as a function of junction temperature

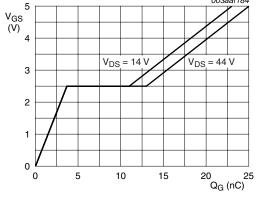


 $T_i = 25 \, ^{\circ}C; V_{DS} = V_{GS}$ 

Fig 13. Sub-threshold drain current as a function of gate-source voltage



 $V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 



 $T_i = 25 \, ^{\circ}C; I_D = 25 \, A$ 

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



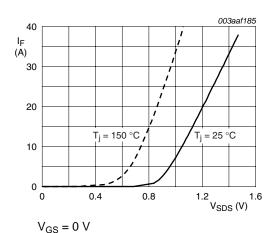
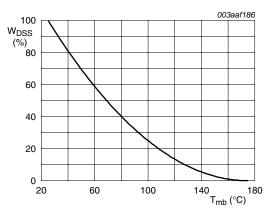


Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



 $I_D = 75 A$ 

Fig 17. Normalised drain-source avalanche energy as a function of mounting-base temperature.

## 7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A

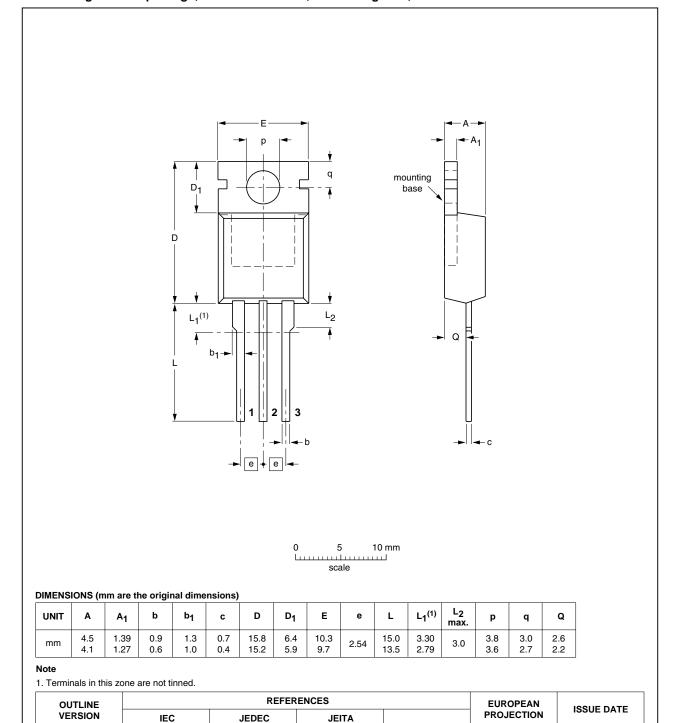


Fig 18. Package outline SOT78A (TO-220AB)

BUK9575-100A

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03-01-22

05-03-14

3-lead TO-220AB

SOT78A

## 8. Revision history

### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9575-100A v.3	20110426	Product data sheet	-	BUK9575_9675-100A_2
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identit guidelines of NXP Semiconductors.</li> </ul>			
	<ul> <li>Legal texts I</li> </ul>	have been adapted to the	new company nam	e where appropriate.
	<ul> <li>Type number</li> </ul>	er BUK9575-100A separa	ted from data sheet	BUK9575_9675-100A_2.
BUK9575_9675-100A_2	20001001	Product specification	-	BUK9575_9675-100A_1

## 9. Legal information

#### 9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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#### N-channel TrenchMOS logic level FET

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